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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/755,047	CHIA ET AL.	
Examiner	Art Unit	
Ida M. Soward	2822	

SEARCHED			
Class	Subclass	Date	Examiner
257	13, 79, 81, 95, 99-100	10/2/2005	IMS
257	666, 784	10/16/2006	IMS
257	787-788	10/16/2006	IMS .
257	793	10/16/2006	IMS

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	ence Search Itout	10/16/2006	IMS

SEARCH N (INCLUDING SEARC		)
	DATE	EXMR
EAST See Search History Printout	10/2/2005	IMS
EAST See Search History Printout	3/31/2006	IMS
EAST See Search History Printout	10/16/2006	IMS
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